

IN THE SPECIFICATION:

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Page 3, Lines 11-23:

Such an analyzer, however, cannot effectively eliminate noise-causing scattering light caused by scratch or deflection of the cell wall and noise-causing scattering light occurring at the interface between the inside surface of the cell and the sample contained therein, though it is capable of eliminating noise-causing scattering light occurring at the interface between the outside surface of the cell and the outside air interface. Particularly recently, heavy use has been made of a disposable cell made of a resin such as a plastic. Such a cell is susceptible to scratch, deflection, or streak resulting from heterogeneity of a plastic and appearing like a string in the cell wall, which are responsible for the occurrence of noise-causing scattering light

Page 14, Lines 17-26, through Page 15, Lines 1-8:

According to the present invention having been described in detail, a very simple arrangement such that an existing cell, for example, is mounted at a different angle than in a conventional analyzer, makes it possible to largely reduce the influence on measurement by noise-causing scattering light which is caused by minute unevenness (scratch) on the cell surface or streaks in the cell wall or which occurs at the interface between the outside surface of the cell and outside air or between the inside surface of the cell and the sample due to the difference in refractive index between them. Since the intensity distribution direction of such noise-causing scattering light greatly depends on the angle of irradiation of laser light on the outside surface or inside surface of the cell, inclining the inside outside surface or inside surface of the cell will make it possible to cause noise light to travel in a direction different from the direction of the

optical axis of scattering light to be measured.